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Application/Control No.	Applicant(s)/Patent under Reexamination	:
10/691,347	ZHAO ET AL.	
Examiner	Art Unit	
Nhan T. Tran	2622	!

	SEAR	CHED	•
Class	Subclass	Date	Examiner
348	308	5/8/2007	NT
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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	search - see ory printout	5/8/2007	NT .	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST search (USPAT, PGPUB, JPO. EPO, DERWENT, IBM_TDB)	5/8/2007	NT	
348/294-324 348/296, 297 (text search - see search history printout)	5/8/2007	NT	
250/208.1 257/291,292 (text search - see search history printout)	5/8/2007	NT	
text search all classes 348, 250 and 257	5/8/2007	NT	
Inventorship search - see search history printout			
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